Sear	ch Note	es

Application/Control No.	Applicant(s)/Patent under Reexamination
10/764,546	ISHIZUKA ET AL.
Examiner	Art Unit
Ly T. TRAN	2853

	SEARCHED			
Class	Subclass	Date	Examiner	
347	37,49,108	4/12/2006	LT	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
347	37,208,49	4/12/2006	LT	
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SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
text search	4/12/2006	LT
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